



Ref. Certif. No.

**AT 4432/M2**

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT  
(IECEE) CB SCHEME

## CB TEST CERTIFICATE

Product

Fully integrated time-of-flight ranging sensor module

Name and address of the applicant

STMicroelectronics (R&D) LTD.  
1 Tanfield, 1st floor,  
EH3 5DA Edinburgh, United Kingdom

Name and address of the manufacturer

Shenzhen STS Microelectronics Co. Ltd  
16, Tao Hua Road Futian Free Trade Zone,  
518048 Shenzhen, China

Name and address of the factory

Shenzhen STS Microelectronics Co. Ltd  
16, Tao Hua Road Futian Free Trade Zone,  
518048 Shenzhen, China

Note: When more than one factory, please report on page 2

☐ Additional Information on page 2

Ratings and principal characteristics

Laser Class 1

Trademark / Brand (if any)



Customer's Testing Facility (CTF) Stage used

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Model / Type Ref.

VL53L4ED

Additional information (if necessary may also be reported on page 2)

In addition to CB/AT 4432/M1, dated 2022-03-10.

Additional type.

Only hazards resulting from laser radiation have been addressed.  
See test report for information about National and/or Group Differences.

☐ Additional Information on page 2

A sample of the product was tested and found to be in conformity with

IEC 60825-1:2014

As shown in the Test Report Ref. No. which forms part of this Certificate

LE-L74/23

This CB Test Certificate is issued by the National Certification Body



**Österreichischer Verband für Elektrotechnik**

OVE Certification

Kahlenberger Str. 2A, 1190 Wien, Austria

*T. Neumayer*

Digitally signed by T. Neumayer  
Email: t.neumayer@ove.at



Date: 2023-06-02

Signature: Dipl.-Ing. T. Neumayer